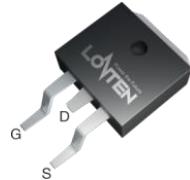
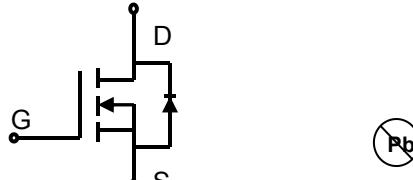


Lonten N-channel 100V, 145A, 4.35mΩ Power MOSFET

<p>Description</p> <p>These N-Channel enhancement mode power field effect transistors are using shielded gate trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.</p> <p>Features</p> <ul style="list-style-type: none"> ◆ 100V, 145A, $R_{DS(on).max} = 4.35\text{m}\Omega$ @ $V_{GS} = 10\text{V}$ ◆ Improved dv/dt capability ◆ Fast switching ◆ 100% EAS Guaranteed ◆ Green device available <p>Applications</p> <ul style="list-style-type: none"> ◆ Motor Drives ◆ UPS ◆ DC-DC Converter 	<p>Product Summary</p> <table border="0"> <tr> <td>V_{DSS}</td><td>100V</td></tr> <tr> <td>$R_{DS(on).max}$ @ $V_{GS}=10\text{V}$</td><td>4.35mΩ</td></tr> <tr> <td>I_D</td><td>145A</td></tr> </table> <p>Pin Configuration</p>  <p>TO-263</p>  <p>N-Channel MOSFET</p>	V_{DSS}	100V	$R_{DS(on).max}$ @ $V_{GS}=10\text{V}$	4.35mΩ	I_D	145A
V_{DSS}	100V						
$R_{DS(on).max}$ @ $V_{GS}=10\text{V}$	4.35mΩ						
I_D	145A						

Absolute Maximum Ratings $T_c = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	100	V
Continuous drain current <small>($T_c = 25^\circ\text{C}$)</small>	I_D	145	A
<small>($T_c = 100^\circ\text{C}$)</small>		92	A
Pulsed drain current ¹⁾	I_{DM}	480	A
Gate-Source voltage	V_{GSS}	± 20	V
Avalanche energy ²⁾	E_{AS}	272	mJ
Power Dissipation	P_D	156	W
Storage Temperature Range	T_{STG}	-55 to +150	°C
Operating Junction Temperature Range	T_J	-55 to +150	°C

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.8	°C/W
Thermal Resistance, Junction-to-Ambient ³⁾	$R_{\theta JA}$	75	°C/W

Package Marking and Ordering Information

Device	Device Package	Marking	Units/Reel
LSGE10R042	TO-263	LSGE10R042	800

Electrical Characteristics
 $T_J = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static characteristics						
Drain-source breakdown voltage	BV_{DSS}	$V_{\text{GS}}=0 \text{ V}, I_D=250\mu\text{A}$	100	---	---	V
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_D=250\mu\text{A}$	2.0	---	4.0	V
Drain-source leakage current	I_{DSS}	$V_{\text{DS}}=100 \text{ V}, V_{\text{GS}}=0 \text{ V}, T_J = 25^\circ\text{C}$	---	---	1	μA
		$V_{\text{DS}}=100 \text{ V}, V_{\text{GS}}=0 \text{ V}, T_J = 150^\circ\text{C}$	---	---	100	μA
Gate leakage current, Forward	I_{GSSF}	$V_{\text{GS}}=20 \text{ V}, V_{\text{DS}}=0 \text{ V}$	---	---	100	nA
Gate leakage current, Reverse	I_{GSSR}	$V_{\text{GS}}=-20 \text{ V}, V_{\text{DS}}=0 \text{ V}$	---	---	-100	nA
Drain-source on-state resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=10 \text{ V}, I_D=40 \text{ A}, T_J = 25^\circ\text{C}$	---	4.0	4.35	$\text{m}\Omega$
		$T_J = 150^\circ\text{C}$	---	7.2	---	
		$V_{\text{DS}}=20 \text{ V}, I_D=40 \text{ A}$	---	120	---	S
Dynamic characteristics						
Input capacitance	C_{iss}	$V_{\text{DS}} = 50 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 250 \text{ kHz}$	---	3838	---	pF
Output capacitance	C_{oss}		---	1252	---	
Reverse transfer capacitance	C_{rss}		---	13.4	---	
Turn-on delay time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 40 \text{ V}, V_{\text{GS}} = 15 \text{ V}, I_D = 60 \text{ A}$	---	29.4	---	ns
Rise time	t_r		---	29.2	---	
Turn-off delay time	$t_{\text{d}(\text{off})}$		---	80.2	---	
Fall time	t_f		---	30.8	---	
Gate resistance	R_g	$V_{\text{GS}}=0 \text{ V}, V_{\text{DS}}=0 \text{ V}, f=1 \text{ MHz}$	---	2.0	---	Ω
Gate charge characteristics						
Gate to source charge	Q_{gs}	$V_{\text{DS}}=80 \text{ V}, I_D=80 \text{ A}, V_{\text{GS}}=10 \text{ V}$	---	20.5	---	nC
Gate to drain charge	Q_{gd}		---	16	---	
Gate charge total	Q_g		---	65	---	
Gate plateau voltage	V_{plateau}		---	5.5	---	
Output Charge	Q_{oss}	$V_{\text{DS}}=80 \text{ V}, V_{\text{GS}}=0 \text{ V}$	---	138	---	nC
Drain-Source diode characteristics and Maximum Ratings						
Continuous Source Current	I_s		---	---	111	A
Pulsed Source Current	I_{SM}		---	---	444	A
Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0 \text{ V}, I_s=80 \text{ A}, T_J=25^\circ\text{C}$	---	---	1.4	V
Reverse Recovery Time	t_{rr}	$I_s=80 \text{ A}, dI/dt=100 \text{ A/us}, T_J=25^\circ\text{C}$	---	55.6	---	ns
Reverse Recovery Charge	Q_{rr}		---	233	---	nC

Notes:

1: Repetitive Rating: Pulse width limited by maximum junction temperature.

 2: $V_{\text{DD}}=50 \text{ V}, V_{\text{GS}}=10 \text{ V}, L=0.5 \text{ mH}, I_{\text{AS}}=33 \text{ A}, R_g=25 \Omega$, Starting $T_J=25^\circ\text{C}$.

 3: The value of R_{thJA} is measured by placing the device in a still air box which is one cubic foot.

Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

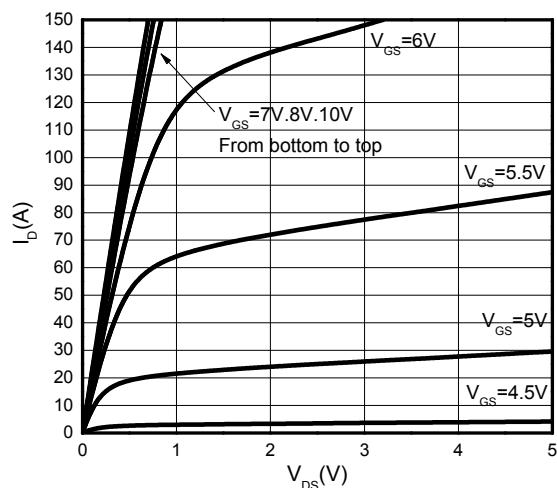


Figure 3. On-Resistance vs.Drain Current

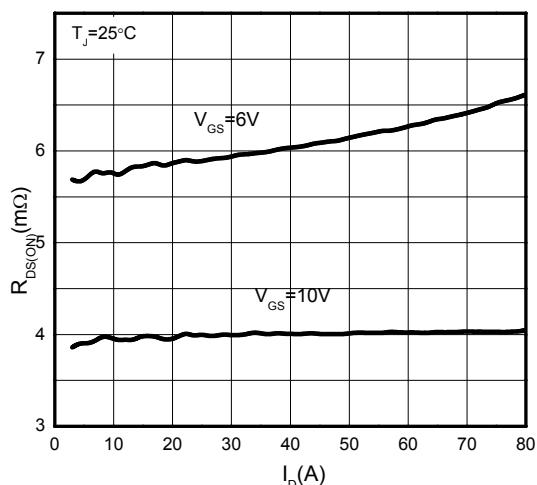


Figure 5.Breakdown Voltage vs.Temperature

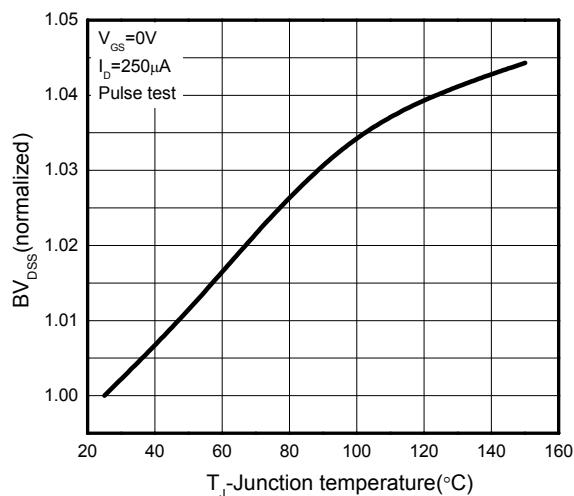


Figure 2. Transfer Characteristics

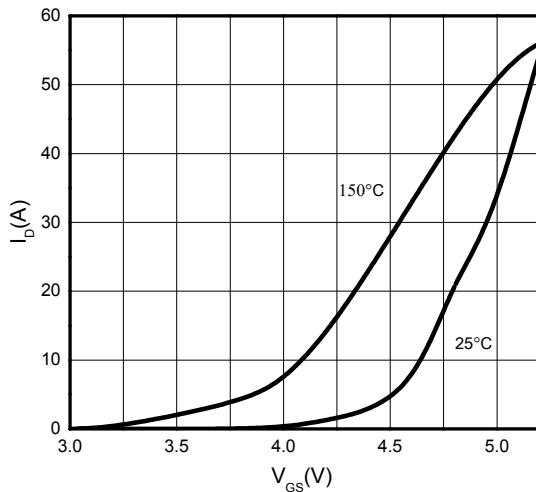


Figure 4.On-Resistance vs.Temperature

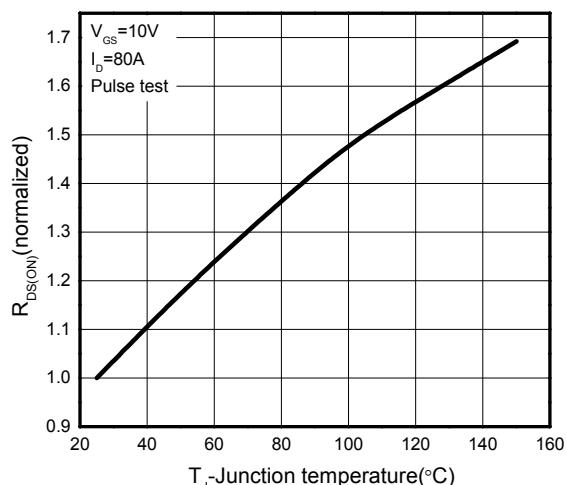


Figure 6.Threshold Voltage vs.Temperature

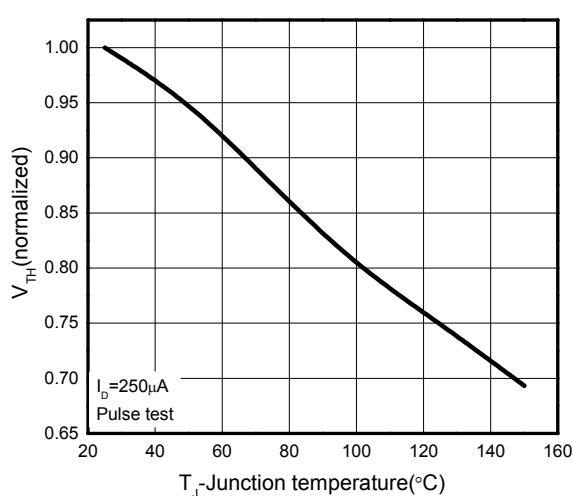


Figure 7.R_{ds(on)} vs. Gate Voltage

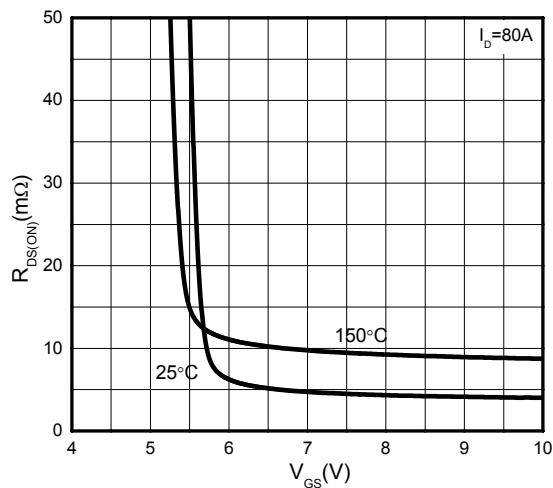


Figure 9.Capacitance Characteristics

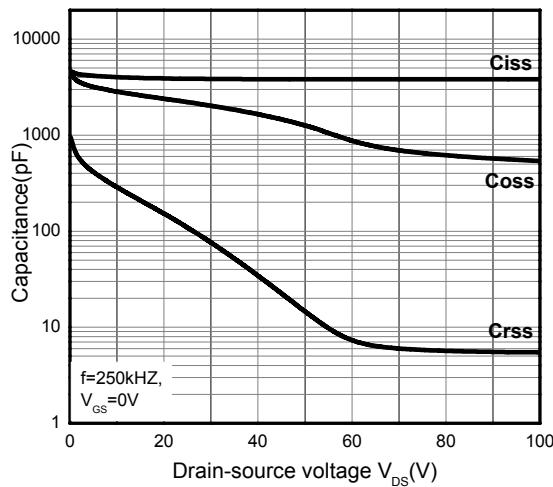


Figure 11.Drain Current Derating

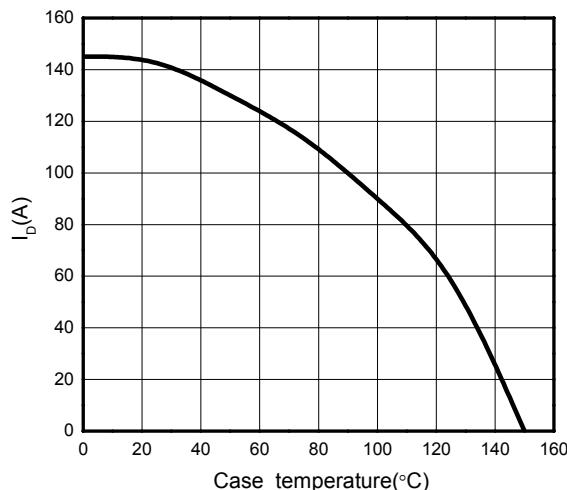


Figure 8.Body-Diode Characteristics

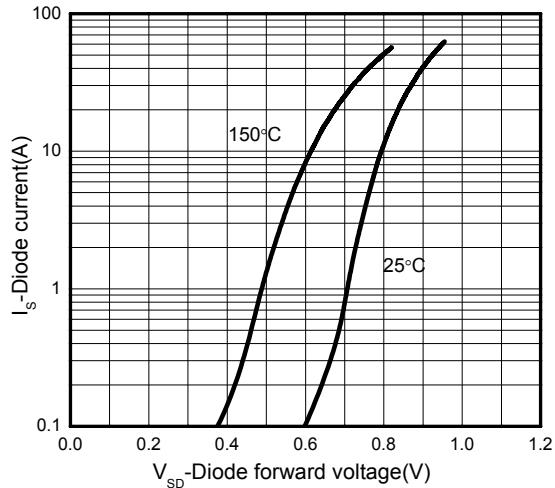


Figure 10.Gate Charge Characteristics

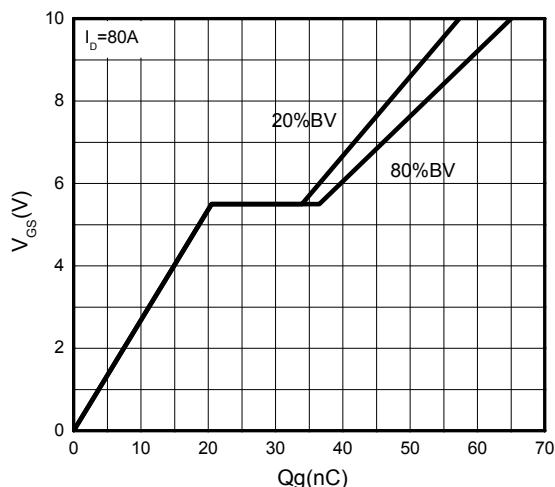


Figure 12.Power Dissipation vs.Temperature

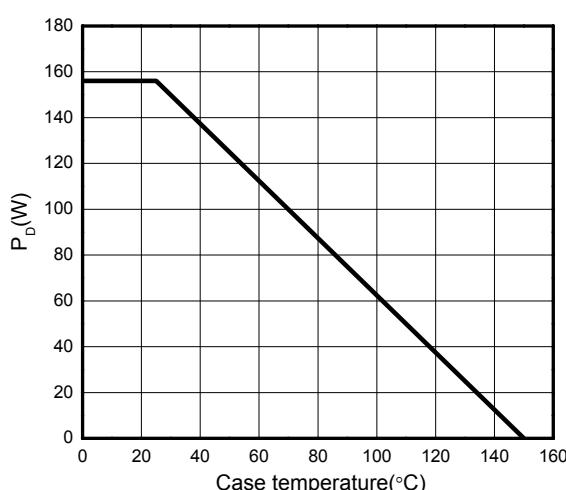


Figure 13: Safe Operating Area

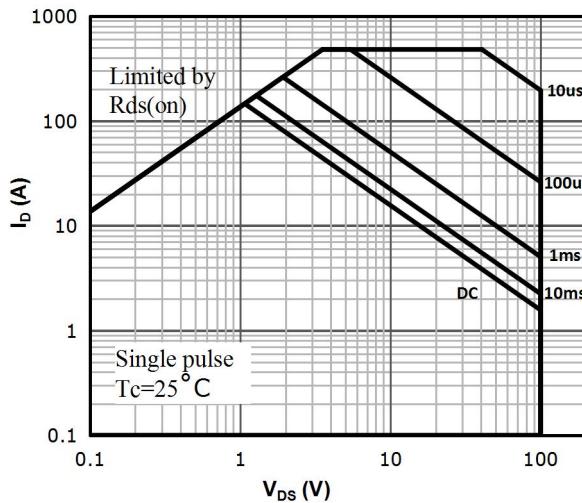
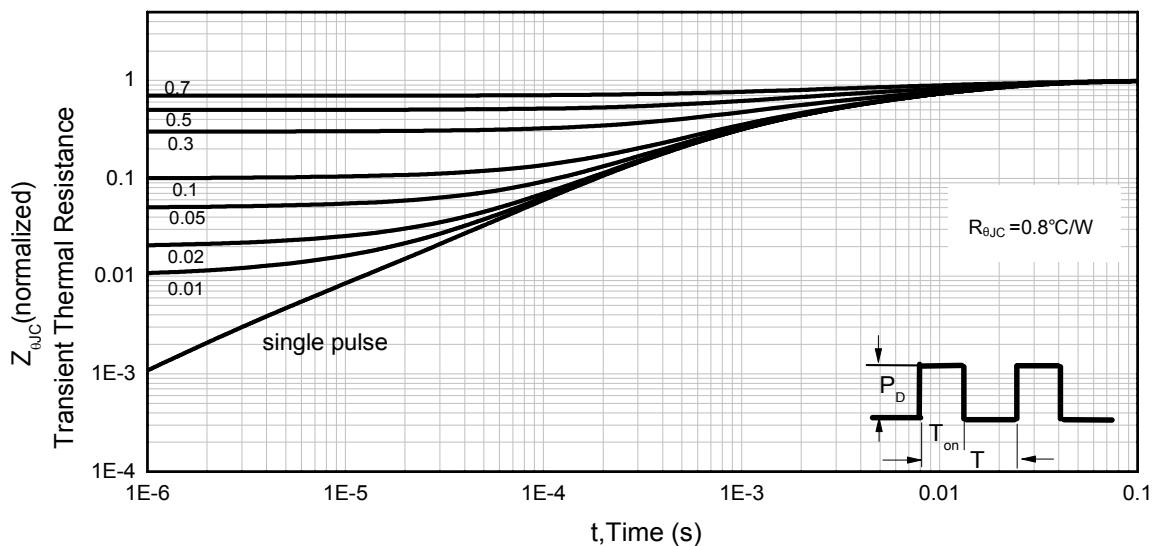
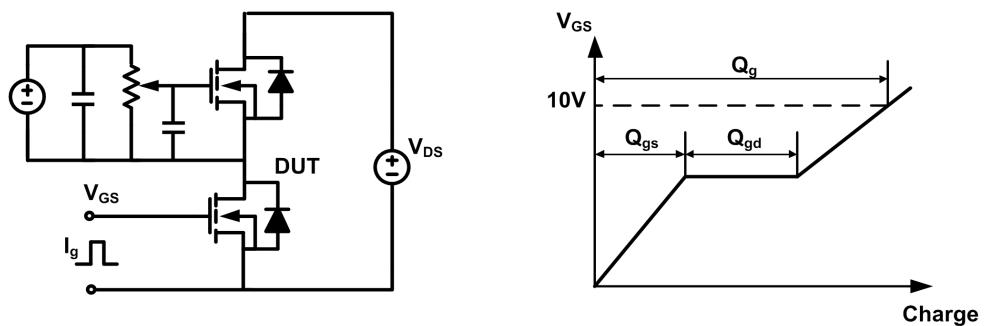


Figure 14. Normalized Maximum Transient Thermal Impedance ($R_{\theta JC}$)

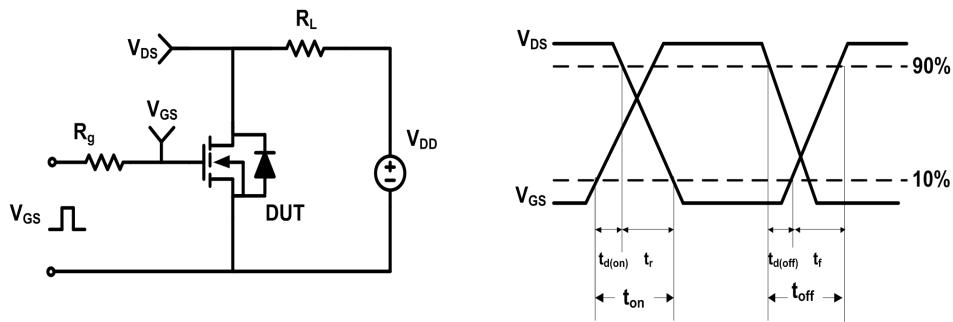


Test Circuit & Waveforms

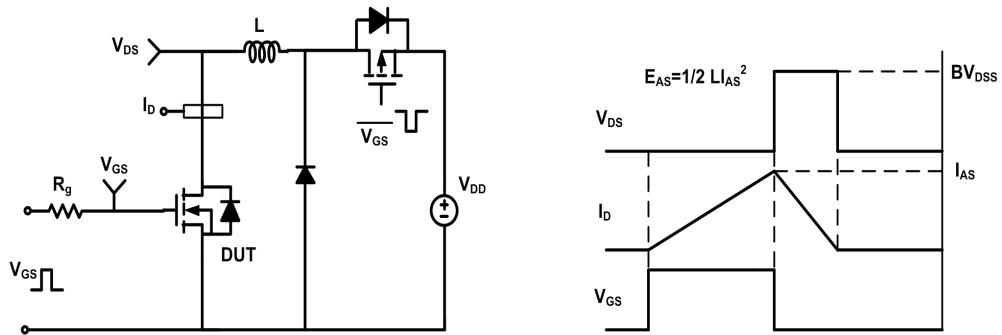
Gate Charge Test Circuit & Waveform



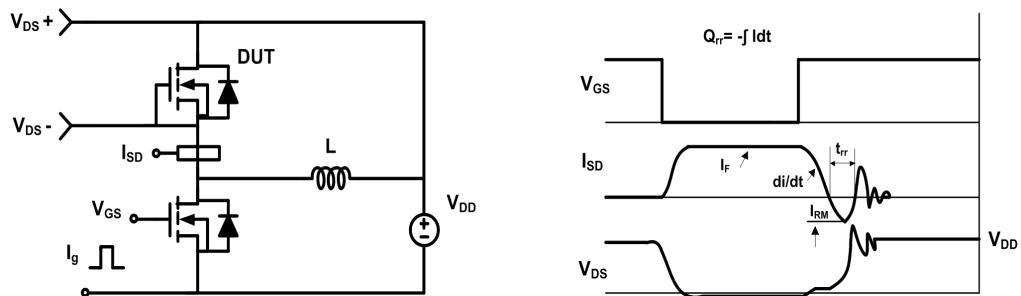
Resistive Switching Test Circuit & Waveform

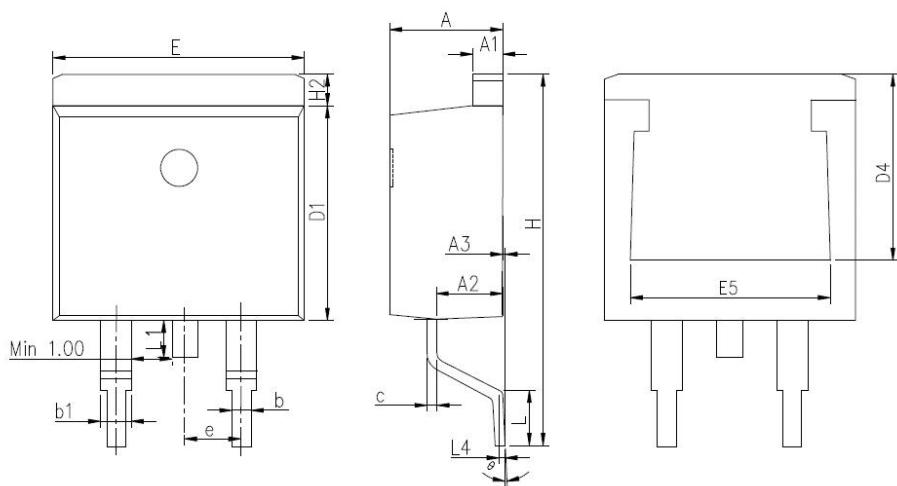


Unclamped Inductive Switching (UIS) Test Circuit & Waveform



Diode Recovery Test Circuit & Waveform



Mechanical Dimensions for TO-263


DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES	
SYMBOL	MIN	MAX	MIN	MAX
A	4.36	4.8	0.172	0.189
A1	1.19	1.42	0.047	0.056
A2	2.2	2.96	0.087	0.117
A3	0	0.25	0	0.010
b	0.7	0.96	0.028	0.038
b1	1.17	1.47	0.046	0.058
c	0.3	0.69	0.012	0.027
D1	8.5	9.5	0.335	0.374
D4	6.6	-	0.260	-
E	9.8	10.55	0.386	0.415
E5	7.06	8.7	0.278	0.343
e	2.54BSC		0.1BSC	
H	14.7	15.7	0.579	0.618
H2	0.95	1.65	0.037	0.065
L	1.9	2.8	0.075	0.110
L1	-	1.78	-	0.070
L4	0.25BSC		0.01BSC	
θ	0°	9°	0°	9°

Revision History

LSGE10R042

Revision:2020-12-30 ,Rev 1.1

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